National Institute of Advanced Manufacturing Technology Central Instrument Facility

Requisition form for X-Ray Diffraction: Residual Stress Analysis

							Date:	
Name of the user:					Name of the supervisor:			
Course: Ph.D. / M. Tech / B. Tech / ADC					Department:			
Contact No.					No. of Samples submitted:			
Email ID:					Nature of samples: Hazardous / Non-hazardou			
Dina	11 110.				Tratate of	sumpres: 110	izaraoas / 1	COII HUZUIGOU
Test/s	s to be do	ne: Please	provide	the follow	ing details:			
S	Sample	Material	Stress	Scan	hkl	Young's	Poisson's	Sample
No.	Name	Name	free angle	Range 2θ= to_	value	modulus (MPa)	ratio (v)	Recollectio (Yes/No)
			angic	2010_	-	(IVII a)		(103/110)
	rks, if any		Sign	ature of s	upervisor		Signature o	f HOD
				<u>For</u>	CIF Use			
Date of Completion:					Signature of Technician			
				Details	of Paymer	 <u>nt</u>		
Nam	e of the u	ser/payer:						
		s/test to be	done:					
		. slot requii						
Total amount paid: Rs.								
Date	of Transa	action:						
Mode of Payment:				UPI app (G-Pay / Phonepe / Paytm / Whatsapp / others) / NEFT / IMPS				
Tran	saction II	D:						

Yes / No

Signature of user

Copy of transaction attached: